

P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$ (Max.)	I _D (A)	Q _g (Typ.)			
- 20	$0.030 \text{ at V}_{GS} = -4.5 \text{ V}$	-10 ^a	18 nC			
- 20	0.040 at V _{GS} = - 2.5 V	-9 ^a	10110			

FEATURES

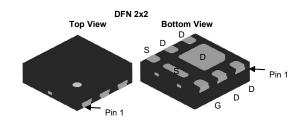
- TrenchFET[®] Power MOSFET
- Thermally Enhanced DFN2X2 Package
 - Small Footprint Area
 - Low On-Resistance

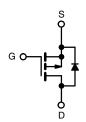


ROHS COMPLIANT HALOGEN FREE

APPLICATIONS

 Load Switch, PA Switch, and Battery Switch for Portable Devices





P-Channel MOSFET

ABSOLUTE MAXIMUM RATING	S (T _A = 25 °C, unle	ess otherwise no	oted)		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	- 20	V		
Gate-Source Voltage	V_{GS}	± 12	V		
	T _C = 25 °C		- 10 ^a		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C		- 8 ^a		
Continuous Brain Guitent (1) = 130 G)	T _A = 25 °C	I _D	- 10 ^{b, c}		
	T _A = 70 °C		- 8 ^{b, c}	Α	
Pulsed Drain Current (t = 300 μs)		I _{DM}	- 30		
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	- 10 ^a		
Continuous Source-Diam Diode Current	T _A = 25 °C	'S	- 2.5 ^{b, c}		
	T _C = 25 °C		17		
Maximum Power Dissipation	T _C = 70 °C	P _D	11	W	
Maximum i ower bissipation	T _A = 25 °C	, p	3.3 ^{b, c}	VV	
	T _A = 70 °C		2.1 ^{b, c}	1	
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperatur		250	C		

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R_{thJA}	28	38	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	5.6	7.5	O/ VV		

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. See solder profile The DFN2X2 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 80 °C/W.

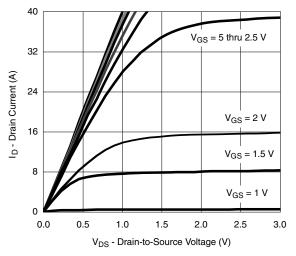


Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	,				l	l	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J I _D = - 250 μA		- 11		\//0C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		2.7		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.4		- 1	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current		$V_{DS} = -12 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	μΑ	
	I _{DSS}	V_{DS} = - 12 V, V_{GS} = 0 V, T_{J} = 55 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 20			Α	
		$V_{GS} = -4.5 \text{ V}, I_D = -6.7 \text{ A}$		0.030	0.034		
		V _{GS} = - 2.5 V, I _D = - 6.2 A		0.040	0.043	1	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -1.8 \text{ V}, I_D = -2.3 \text{ A}$		0.042	0.046	Ω	
		V _{GS} = - 1.5 V, I _D = - 1 A		0.050	0.055		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 6.7 A		30		S	
Dynamic ^b						L	
Input Capacitance	C _{iss}			1600		pF	
Output Capacitance	C _{oss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		430			
Reverse Transfer Capacitance	C _{rss}			370			
Total Gate Charge	Qg	$V_{DS} = -6 \text{ V}, V_{GS} = -8 \text{ V}, I_{D} = -10 \text{ A}$		38	54	nC	
				23	33		
Gate-Source Charge	Q_{gs}	V_{DS} = - 6 V, V_{GS} = - 4.5 V, I_D = - 10 A		3			
Gate-Drain Charge	Q_{gd}			6.5			
Gate Resistance	R_g	f = 1 MHz		7		Ω	
Turn-On Delay Time	t _{d(on)}			20	30		
Rise Time	t _r	V_{DD} = - 6 V, R_L = 0.75 Ω		40	60		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ - 8 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		65	100		
Fall Time	t _f			40	60	ns	
Turn-On Delay Time	t _{d(on)}			10	15	113	
Rise Time	t _r	V_{DD} = - 6 V, R_L = 0.75 Ω		12	20	-	
Turn-Off Delay Time	Delay Time $t_{d(off)}$ $I_D \cong -8 \text{ A}$			70	105		
Fall Time	t _f			40	60		
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 10	A	
Pulse Diode Forward Current	I _{SM}				30	, , , , , , , , , , , , , , , , , , ,	
Body Diode Voltage	V_{SD}	$I_S = -8 \text{ A}, V_{GS} = 0 \text{ V}$		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			40	60	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 8 A, di/dt = 100 A/μs, T _J = 25 °C		20	30	nC	
Reverse Recovery Fall Time	t _a			14		ns	
Reverse Recovery Rise Time	t _b			26]		

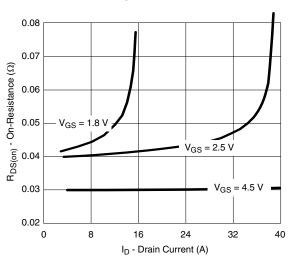
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

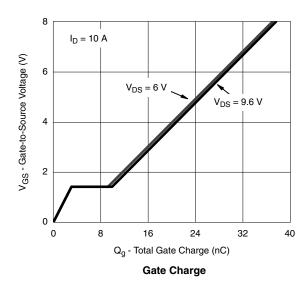


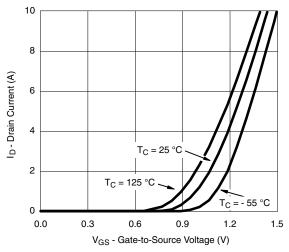


Output Characteristics

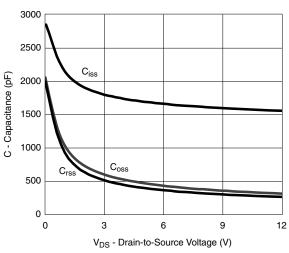


On-Resistance vs. Drain Current and Gate Voltage

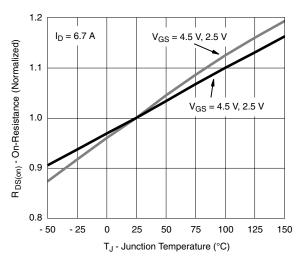




Transfer Characteristics

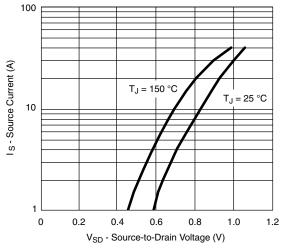


Capacitance

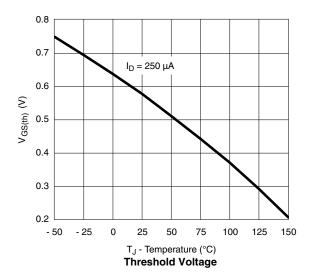


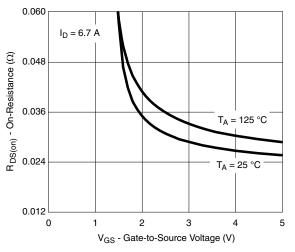
On-Resistance vs. Junction Temperature



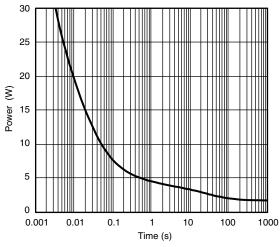


Soure-Drain Diode Forward Voltage

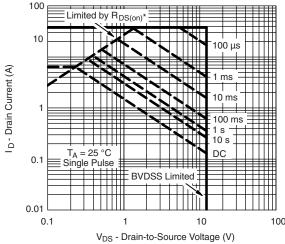




On-Resistance vs. Gate-to-Source Voltage



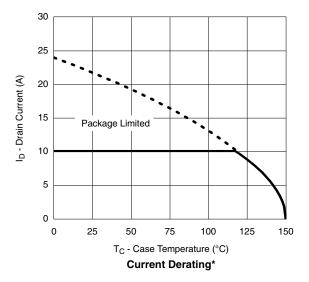
Single Pulse Power, Junction-to-Ambient

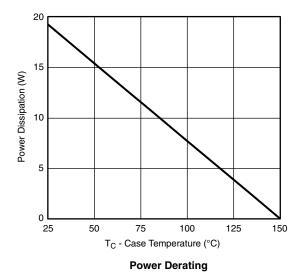


 $^{*}V_{GS}$ > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area, Junction-to-Ambient





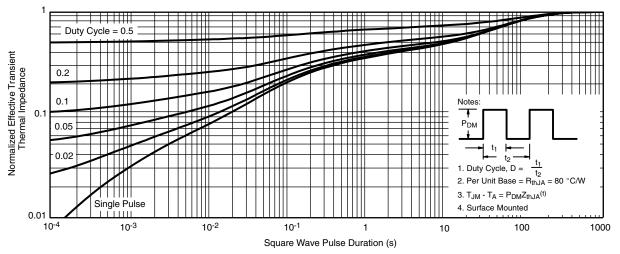


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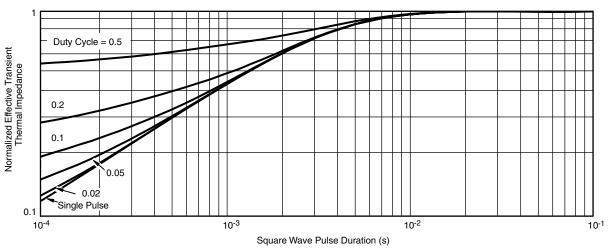
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 $^{^{\}star}$ The power dissipation P_D is based on $T_{J(max)}$ = 150 $^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



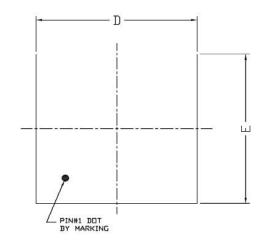
Normalized Thermal Transient Impedance, Junction-to-Case

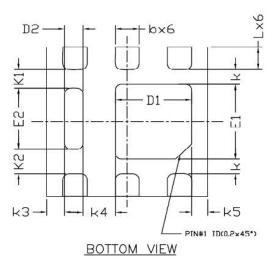
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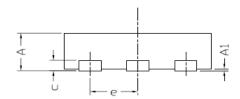
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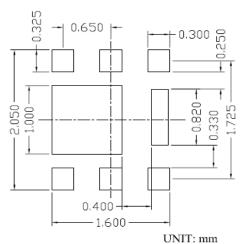
DFN2x2 _6L_EP1_S PACKAGE OUTLINE







RECOMMENDED LAND PATTERN



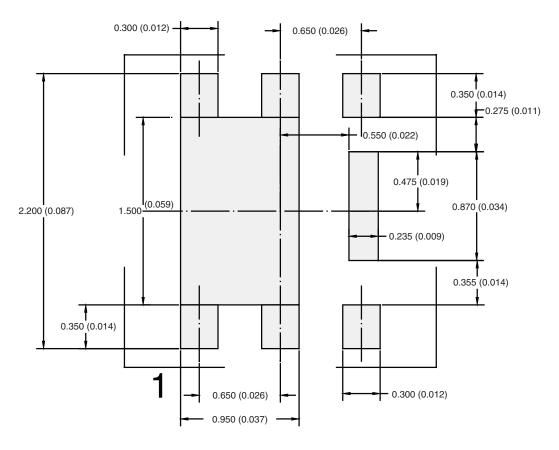
SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES			
BIMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
A	0.50	0.55	0.60	0.020	0.022	0.024	
A1	0.00		0.05	0.000		0.002	
ь	0. 25	0.30	0.35	0.010	0.012	0.014	
c	0. 152 REF				0.006 REF		
D	1.90	2.00	2.10	0.075	0.079	0.083	
D1	0.85	0.95	1.05	0.033	0.037	0.041	
D2	0.13	0. 23	0.33	0.005	0.009	0.013	
E	1.90	2.00	2.10	0.075	0.079	0.083	
E1	0.90	1.00	1.10	0.035	0.039	0.043	
E2	0.72	0.82	0.92	0.028	0.032	0.036	
e	0.65 BSC			0. 026 BSC			
K	0. 20 BSC			0.008 BSC			
K1	0. 25 BSC			0.010 BSC			
K2	0. 33 BSC			0. 013 BSC			
K3	0. 22 BSC			0.009 BSC			
K4	0.40 BSC			0.016 BSC			
K5	0. 20 BSC			0.008 BSC			
L	0.25	0.30	0.35	0.010	0.012	0.014	

NOTE

CONTROLLING DIMENSION IS MILLIMETER.
CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



RECOMMENDED PAD LAYOUT FOR DFN2X2



Dimensions in mm/(Inches)



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